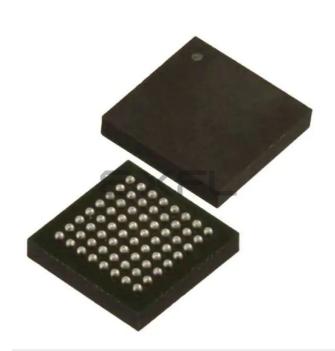
E. Kentice Semiconductor Corporation - <u>LCMX02-256HC-4UMG64I Datasheet</u>



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Details

Product Status	Active
Number of LABs/CLBs	32
Number of Logic Elements/Cells	256
Total RAM Bits	-
Number of I/O	44
Number of Gates	-
Voltage - Supply	2.375V ~ 3.465V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	64-VFBGA
Supplier Device Package	64-UCBGA (4x4)
Purchase URL	https://www.e-xfl.com/product-detail/lattice-semiconductor/lcmxo2-256hc-4umg64i

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Table 1-1. MachXO2™ Family Selection Guide

LUTs			XO2-640	XO2-640U ¹	702-1200	702-12000	702-2000	702-20000	XU2-4000	XO2-7000
2010		256	640	640	1280	1280	2112	2112	4320	6864
Distributed RAM (kbi	ts)	2	5	5	10	10	16	16	34	54
EBR SRAM (kbits)		0	18	64	64	74	74	92	92	240
Number of EBR SRA kbits/block)	M Blocks (9	0	2	7	7	8	8	10	10	26
UFM (kbits)		0	24	64	64	80	80	96	96	256
Device Options:	HC ²	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes
	HE ³						Yes	Yes	Yes	Yes
	ZE ⁴	Yes	Yes		Yes		Yes		Yes	Yes
Number of PLLs		0	0	1	1	1	1	2	2	2
Hardened	12C	2	2	2	2	2	2	2	2	2
Functions:	SPI	1	1	1	1	1	1	1	1	1
	Timer/Coun- ter	1	1	1	1	1	1	1	1	1
Packages						ю				
25-ball WLCSP⁵ (2.5 mm x 2.5 mm, 0	.4 mm)				18					
32 QFN ⁶ (5 mm x 5 mm, 0.5 m	nm)	21			21					
48 QFN ^{8, 9} (7 mm x 7 mm, 0.5 n	וm)	40	40							
49-ball WLCSP⁵ (3.2 mm x 3.2 mm, 0	.4 mm)						38			
64-ball ucBGA (4 mm x 4 mm, 0.4 m	וm)	44								
84 QFN ⁷ (7 mm x 7 mm, 0.5 m	וm)								68	
100-pin TQFP (14 mm x 14 mm)		55	78		79		79			
132-ball csBGA (8 mm x 8 mm, 0.5 m	וm)	55	79		104		104		104	
144-pin TQFP (20 mm x 20 mm)				107	107		111		114	114
184-ball csBGA ⁷ (8 mm x 8 mm, 0.5 m	וm)								150	
256-ball caBGA (14 mm x 14 mm, 0.8	3 mm)						206		206	206
256-ball ftBGA (17 mm x 17 mm, 1.0) mm)					206	206		206	206
332-ball caBGA (17 mm x 17 mm, 0.8	3 mm)								274	278
484-ball ftBGA (23 mm x 23 mm, 1.0) mm)							278	278	334

1. Ultra high I/O device.

2. High performance with regulator – VCC = 2.5 V, 3.3 V

3. High performance without regulator $-V_{CC} = 1.2 V$ 4. Low power without regulator $-V_{CC} = 1.2 V$ 5. WLCSP package only available for ZE devices.

6. 32 QFN package only available for HC and ZE devices.

7. 184 csBGA package only available for HE devices.

8. 48-pin QFN information is 'Advanced'.

9. 48 QFN package only available for HC devices.



The logic blocks, Programmable Functional Unit (PFU) and sysMEM EBR blocks, are arranged in a two-dimensional grid with rows and columns. Each row has either the logic blocks or the EBR blocks. The PIO cells are located at the periphery of the device, arranged in banks. The PFU contains the building blocks for logic, arithmetic, RAM, ROM, and register functions. The PIOs utilize a flexible I/O buffer referred to as a sysIO buffer that supports operation with a variety of interface standards. The blocks are connected with many vertical and horizontal routing channel resources. The place and route software tool automatically allocates these routing resources.

In the MachXO2 family, the number of sysIO banks varies by device. There are different types of I/O buffers on the different banks. Refer to the details in later sections of this document. The sysMEM EBRs are large, dedicated fast memory blocks; these blocks are found in MachXO2-640/U and larger devices. These blocks can be configured as RAM, ROM or FIFO. FIFO support includes dedicated FIFO pointer and flag "hard" control logic to minimize LUT usage.

The MachXO2 registers in PFU and sysl/O can be configured to be SET or RESET. After power up and device is configured, the device enters into user mode with these registers SET/RESET according to the configuration setting, allowing device entering to a known state for predictable system function.

The MachXO2 architecture also provides up to two sysCLOCK Phase Locked Loop (PLL) blocks on MachXO2-640U, MachXO2-1200/U and larger devices. These blocks are located at the ends of the on-chip Flash block. The PLLs have multiply, divide, and phase shifting capabilities that are used to manage the frequency and phase relationships of the clocks.

MachXO2 devices provide commonly used hardened functions such as SPI controller, I²C controller and timer/ counter. MachXO2-640/U and higher density devices also provide User Flash Memory (UFM). These hardened functions and the UFM interface to the core logic and routing through a WISHBONE interface. The UFM can also be accessed through the SPI, I²C and JTAG ports.

Every device in the family has a JTAG port that supports programming and configuration of the device as well as access to the user logic. The MachXO2 devices are available for operation from 3.3 V, 2.5 V and 1.2 V power supplies, providing easy integration into the overall system.

PFU Blocks

The core of the MachXO2 device consists of PFU blocks, which can be programmed to perform logic, arithmetic, distributed RAM and distributed ROM functions. Each PFU block consists of four interconnected slices numbered 0 to 3 as shown in Figure 2-3. Each slice contains two LUTs and two registers. There are 53 inputs and 25 outputs associated with each PFU block.



ROM Mode

ROM mode uses the LUT logic; hence, slices 0-3 can be used in ROM mode. Preloading is accomplished through the programming interface during PFU configuration.

For more information on the RAM and ROM modes, please refer to TN1201, Memory Usage Guide for MachXO2 Devices.

Routing

There are many resources provided in the MachXO2 devices to route signals individually or as buses with related control signals. The routing resources consist of switching circuitry, buffers and metal interconnect (routing) segments.

The inter-PFU connections are made with three different types of routing resources: x1 (spans two PFUs), x2 (spans three PFUs) and x6 (spans seven PFUs). The x1, x2, and x6 connections provide fast and efficient connections in the horizontal and vertical directions.

The design tools take the output of the synthesis tool and places and routes the design. Generally, the place and route tool is completely automatic, although an interactive routing editor is available to optimize the design.

Clock/Control Distribution Network

Each MachXO2 device has eight clock inputs (PCLK [T, C] [Banknum]_[2..0]) – three pins on the left side, two pins each on the bottom and top sides and one pin on the right side. These clock inputs drive the clock nets. These eight inputs can be differential or single-ended and may be used as general purpose I/O if they are not used to drive the clock nets. When using a single ended clock input, only the PCLKT input can drive the clock tree directly.

The MachXO2 architecture has three types of clocking resources: edge clocks, primary clocks and secondary high fanout nets. MachXO2-640U, MachXO2-1200/U and higher density devices have two edge clocks each on the top and bottom edges. Lower density devices have no edge clocks. Edge clocks are used to clock I/O registers and have low injection time and skew. Edge clock inputs are from PLL outputs, primary clock pads, edge clock bridge outputs and CIB sources.

The eight primary clock lines in the primary clock network drive throughout the entire device and can provide clocks for all resources within the device including PFUs, EBRs and PICs. In addition to the primary clock signals, MachXO2 devices also have eight secondary high fanout signals which can be used for global control signals, such as clock enables, synchronous or asynchronous clears, presets, output enables, etc. Internal logic can drive the global clock network for internally-generated global clocks and control signals.

The maximum frequency for the primary clock network is shown in the MachXO2 External Switching Characteristics table.

The primary clock signals for the MachXO2-256 and MachXO2-640 are generated from eight 17:1 muxes The available clock sources include eight I/O sources and 9 routing inputs. Primary clock signals for the MachXO2-640U, MachXO2-1200/U and larger devices are generated from eight 27:1 muxes The available clock sources include eight I/O sources, 11 routing inputs, eight clock divider inputs and up to eight sysCLOCK PLL outputs.



Programmable I/O Cells (PIC)

The programmable logic associated with an I/O is called a PIO. The individual PIO are connected to their respective sysIO buffers and pads. On the MachXO2 devices, the PIO cells are assembled into groups of four PIO cells called a Programmable I/O Cell or PIC. The PICs are placed on all four sides of the device.

On all the MachXO2 devices, two adjacent PIOs can be combined to provide a complementary output driver pair.

The MachXO2-640U, MachXO2-1200/U and higher density devices contain enhanced I/O capability. All PIO pairs on these larger devices can implement differential receivers. Half of the PIO pairs on the top edge of these devices can be configured as true LVDS transmit pairs. The PIO pairs on the bottom edge of these higher density devices have on-chip differential termination and also provide PCI support.



Figure 2-11. Group of Four Programmable I/O Cells



Notes:

1. Input gearbox is available only in PIC on the bottom edge of MachXO2-640U, MachXO2-1200/U and larger devices. 2. Output gearbox is available only in PIC on the top edge of MachXO2-640U, MachXO2-1200/U and larger devices.



PIO

The PIO contains three blocks: an input register block, output register block and tri-state register block. These blocks contain registers for operating in a variety of modes along with the necessary clock and selection logic.

Table 2-8	. PIO	Signal	List
-----------	-------	--------	------

Pin Name	I/О Туре	Description
CE	Input	Clock Enable
D	Input	Pin input from sysIO buffer.
INDD	Output	Register bypassed input.
INCK	Output	Clock input
Q0	Output	DDR positive edge input
Q1	Output	Registered input/DDR negative edge input
D0	Input	Output signal from the core (SDR and DDR)
D1	Input	Output signal from the core (DDR)
TD	Input	Tri-state signal from the core
Q	Output	Data output signals to sysIO Buffer
TQ	Output	Tri-state output signals to sysIO Buffer
DQSR90 ¹	Input	DQS shift 90-degree read clock
DQSW90 ¹	Input	DQS shift 90-degree write clock
DDRCLKPOL ¹	Input	DDR input register polarity control signal from DQS
SCLK	Input	System clock for input and output/tri-state blocks.
RST	Input	Local set reset signal

1. Available in PIO on right edge only.

Input Register Block

The input register blocks for the PIOs on all edges contain delay elements and registers that can be used to condition high-speed interface signals before they are passed to the device core. In addition to this functionality, the input register blocks for the PIOs on the right edge include built-in logic to interface to DDR memory.

Figure 2-12 shows the input register block for the PIOs located on the left, top and bottom edges. Figure 2-13 shows the input register block for the PIOs on the right edge.

Left, Top, Bottom Edges

Input signals are fed from the sysIO buffer to the input register block (as signal D). If desired, the input signal can bypass the register and delay elements and be used directly as a combinatorial signal (INDD), and a clock (INCK). If an input delay is desired, users can select a fixed delay. I/Os on the bottom edge also have a dynamic delay, DEL[4:0]. The delay, if selected, reduces input register hold time requirements when using a global clock. The input block allows two modes of operation. In single data rate (SDR) the data is registered with the system clock (SCLK) by one of the registers in the single data rate sync register block. In Generic DDR mode, two registers are used to sample the data on the positive and negative edges of the system clock (SCLK) signal, creating two data streams.



Figure 2-12. MachXO2 Input Register Block Diagram (PIO on Left, Top and Bottom Edges)



Right Edge

The input register block on the right edge is a superset of the same block on the top, bottom, and left edges. In addition to the modes described above, the input register block on the right edge also supports DDR memory mode.

In DDR memory mode, two registers are used to sample the data on the positive and negative edges of the modified DQS (DQSR90) in the DDR Memory mode creating two data streams. Before entering the core, these two data streams are synchronized to the system clock to generate two data streams.

The signal DDRCLKPOL controls the polarity of the clock used in the synchronization registers. It ensures adequate timing when data is transferred to the system clock domain from the DQS domain. The DQSR90 and DDRCLKPOL signals are generated in the DQS read-write block.

Figure 2-13. MachXO2 Input Register Block Diagram (PIO on Right Edge)





Output Register Block

The output register block registers signals from the core of the device before they are passed to the sysIO buffers.

Left, Top, Bottom Edges

In SDR mode, D0 feeds one of the flip-flops that then feeds the output. The flip-flop can be configured as a D-type register or latch.

In DDR generic mode, D0 and D1 inputs are fed into registers on the positive edge of the clock. At the next falling edge the registered D1 input is registered into the register Q1. A multiplexer running off the same clock is used to switch the mux between the outputs of registers Q0 and Q1 that will then feed the output.

Figure 2-14 shows the output register block on the left, top and bottom edges.

Figure 2-14. MachXO2 Output Register Block Diagram (PIO on the Left, Top and Bottom Edges)



Right Edge

The output register block on the right edge is a superset of the output register on left, top and bottom edges of the device. In addition to supporting SDR and Generic DDR modes, the output register blocks for PIOs on the right edge include additional logic to support DDR-memory interfaces. Operation of this block is similar to that of the output register block on other edges.

In DDR memory mode, D0 and D1 inputs are fed into registers on the positive edge of the clock. At the next falling edge the registered D1 input is registered into the register Q1. A multiplexer running off the DQSW90 signal is used to switch the mux between the outputs of registers Q0 and Q1 that will then feed the output.

Figure 2-15 shows the output register block on the right edge.



These gearboxes have three stage pipeline registers. The first stage registers sample the high-speed input data by the high-speed edge clock on its rising and falling edges. The second stage registers perform data alignment based on the control signals UPDATE and SEL0 from the control block. The third stage pipeline registers pass the data to the device core synchronized to the low-speed system clock. Figure 2-16 shows a block diagram of the input gearbox.

Figure 2-16. Input Gearbox





DDR Memory Support

Certain PICs on the right edge of MachXO2-640U, MachXO2-1200/U and larger devices, have additional circuitry to allow the implementation of DDR memory interfaces. There are two groups of 14 or 12 PIOs each on the right edge with additional circuitry to implement DDR memory interfaces. This capability allows the implementation of up to 16-bit wide memory interfaces. One PIO from each group contains a control element, the DQS Read/Write Block, to facilitate the generation of clock and control signals (DQSR90, DQSW90, DDRCLKPOL and DATAVALID). These clock and control signals are distributed to the other PIO in the group through dedicated low skew routing.

DQS Read Write Block

Source synchronous interfaces generally require the input clock to be adjusted in order to correctly capture data at the input register. For most interfaces a PLL is used for this adjustment. However, in DDR memories the clock (referred to as DQS) is not free-running so this approach cannot be used. The DQS Read Write block provides the required clock alignment for DDR memory interfaces. DQSR90 and DQSW90 signals are generated by the DQS Read Write block from the DQS input.

In a typical DDR memory interface design, the phase relationship between the incoming delayed DQS strobe and the internal system clock (during the read cycle) is unknown. The MachXO2 family contains dedicated circuits to transfer data between these domains. To prevent set-up and hold violations, at the domain transfer between DQS (delayed) and the system clock, a clock polarity selector is used. This circuit changes the edge on which the data is registered in the synchronizing registers in the input register block. This requires evaluation at the start of each read cycle for the correct clock polarity. Prior to the read operation in DDR memories, DQS is in tri-state (pulled by termination). The DDR memory device drives DQS low at the start of the preamble state. A dedicated circuit in the DQS Read Write block detects the first DQS rising edge after the preamble state and generates the DDRCLKPOL signal. This signal is used to control the polarity of the clock to the synchronizing registers.

The temperature, voltage and process variations of the DQS delay block are compensated by a set of calibration signals (6-bit bus) from a DLL on the right edge of the device. The DLL loop is compensated for temperature, voltage and process variations by the system clock and feedback loop.

sysIO Buffer

Each I/O is associated with a flexible buffer referred to as a sysIO buffer. These buffers are arranged around the periphery of the device in groups referred to as banks. The sysIO buffers allow users to implement a wide variety of standards that are found in today's systems including LVCMOS, TTL, PCI, SSTL, HSTL, LVDS, BLVDS, MLVDS and LVPECL.

Each bank is capable of supporting multiple I/O standards. In the MachXO2 devices, single-ended output buffers, ratioed input buffers (LVTTL, LVCMOS and PCI), differential (LVDS) and referenced input buffers (SSTL and HSTL) are powered using I/O supply voltage (V_{CCIO}). Each sysIO bank has its own V_{CCIO} . In addition, each bank has a voltage reference, V_{REF} which allows the use of referenced input buffers independent of the bank V_{CCIO} .

MachXO2-256 and MachXO2-640 devices contain single-ended ratioed input buffers and single-ended output buffers with complementary outputs on all the I/O banks. Note that the single-ended input buffers on these devices do not contain PCI clamps. In addition to the single-ended I/O buffers these two devices also have differential and referenced input buffers on all I/Os. The I/Os are arranged in pairs, the two pads in the pair are described as "T" and "C", where the true pad is associated with the positive side of the differential input buffer and the comp (complementary) pad is associated with the negative side of the differential input buffer.



Table 2-11. I/O Support Device by Device

	MachXO2-256, MachXO2-640	MachXO2-640U, MachXO2-1200	MachXO2-1200U MachXO2-2000/U, MachXO2-4000, MachXO2-7000
Number of I/O Banks	4	4	6
		Single-ended (all I/O banks)	Single-ended (all I/O banks)
Type of Input Buffers	Single-ended (all I/O banks) Differential Receivers (all I/O	Differential Receivers (all I/O banks)	Differential Receivers (all I/O banks)
	banks)	Differential input termination (bottom side)	Differential input termination (bottom side)
	Single-ended buffers with	Single-ended buffers with complementary outputs (all I/O banks)	Single-ended buffers with complementary outputs (all I/O banks)
Types of Output Buffers	complementary outputs (all I/O banks)	Differential buffers with true LVDS outputs (50% on top side)	Differential buffers with true LVDS outputs (50% on top side)
Differential Output Emulation Capability	All I/O banks	All I/O banks	All I/O banks
PCI Clamp Support	No	Clamp on bottom side only	Clamp on bottom side only

Table 2-12. Supported Input Standards

		V	CCIO (Ty	p.)	
Input Standard	3.3 V	2.5 V	1.8 V	1.5	1.2 V
Single-Ended Interfaces		•	•		
LVTTL	✓	√ ²	√ ²	√ ²	
LVCMOS33	✓	√ ²	√ ²	√ ²	
LVCMOS25	√ ²	✓	√ ²	√ ²	
LVCMOS18	√ ²	√ ²	✓	√ ²	
LVCMOS15	√ ²	√ ²	√ ²	~	√ ²
LVCMOS12	√ ²	√ ²	√ ²	√ ²	✓
PCI ¹	✓				
SSTL18 (Class I, Class II)	1	✓	✓		
SSTL25 (Class I, Class II)	1	✓			
HSTL18 (Class I, Class II)	✓	✓	✓		
Differential Interfaces	•	•			
LVDS	✓	✓			
BLVDS, MVDS, LVPECL, RSDS	✓	✓			
MIPI ³	✓	✓			
Differential SSTL18 Class I, II	✓	✓	✓		
Differential SSTL25 Class I, II	✓	✓			
Differential HSTL18 Class I, II	✓	✓	✓		

1. Bottom banks of MachXO2-640U, MachXO2-1200/U and higher density devices only.

2. Reduced functionality. Refer to TN1202, MachXO2 sysIO Usage Guide for more detail.

3. These interfaces can be emulated with external resistors in all devices.



There are some limitations on the use of the hardened user SPI. These are defined in the following technical notes:

- TN1087, Minimizing System Interruption During Configuration Using TransFR Technology (Appendix B)
- TN1205, Using User Flash Memory and Hardened Control Functions in MachXO2 Devices

Figure 2-22. SPI Core Block Diagram



Table 2-16 describes the signals interfacing with the SPI cores.

Table 2-16. SPI Core Signal Description

Signal Name	I/O	Master/Slave	Description
spi_csn[0]	0	Master	SPI master chip-select output
spi_csn[17]	0	Master	Additional SPI chip-select outputs (total up to eight slaves)
spi_scsn	I	Slave	SPI slave chip-select input
spi_irq	0	Master/Slave	Interrupt request
spi_clk	I/O	Master/Slave	SPI clock. Output in master mode. Input in slave mode.
spi_miso	I/O	Master/Slave	SPI data. Input in master mode. Output in slave mode.
spi_mosi	I/O	Master/Slave	SPI data. Output in master mode. Input in slave mode.
ufm_sn	I	Slave	Configuration Slave Chip Select (active low), dedicated for selecting the User Flash Memory (UFM).
cfg_stdby	0	Master/Slave	Stand-by signal – To be connected only to the power module of the MachXO2 device. The signal is enabled only if the "Wakeup Enable" feature has been set within the EFB GUI, SPI Tab.
cfg_wake	0	Master/Slave	Wake-up signal – To be connected only to the power module of the MachXO2 device. The signal is enabled only if the "Wakeup Enable" feature has been set within the EFB GUI, SPI Tab.



MachXO2 External Switching Characteristics – HC/HE Devices^{1, 2, 3, 4, 5, 6, 7}

			-	6	_	5	-4		
Parameter	Description	Device	Min.	Max.	Min.	Max.	Min.	Max.	Units
Clocks									
Primary Clo	ocks								
f _{MAX_PRI} ⁸	Frequency for Primary Clock Tree	All MachXO2 devices		388	_	323		269	MHz
t _{W_PRI}	Clock Pulse Width for Primary Clock	All MachXO2 devices	0.5		0.6		0.7		ns
		MachXO2-256HC-HE	_	912	—	939	—	975	ps
		MachXO2-640HC-HE		844		871		908	ps
	Primary Clock Skew Within a	MachXO2-1200HC-HE		868		902		951	ps
^t SKEW_PRI	Device	MachXO2-2000HC-HE		867		897		941	ps
		MachXO2-4000HC-HE		865	—	892		931	ps
		MachXO2-7000HC-HE	_	902	—	942	—	989	ps
Edge Clock	1	1			I.		1		L
f _{MAX_EDGE} ⁸	Frequency for Edge Clock	MachXO2-1200 and larger devices	_	400	_	333	_	278	MHz
Pin-LUT-Pin	Propagation Delay								
t _{PD}	Best case propagation delay through one LUT-4	All MachXO2 devices	_	6.72	_	6.96	_	7.24	ns
General I/O	Pin Parameters (Using Primar	y Clock without PLL)					1		
		MachXO2-256HC-HE	_	7.13	—	7.30	—	7.57	ns
		MachXO2-640HC-HE		7.15	—	7.30		7.57	ns
	Clock to Output – PIO Output	MachXO2-1200HC-HE	_	7.44	—	7.64	—	7.94	ns
t _{CO}	Register	MachXO2-2000HC-HE	_	7.46	—	7.66	—	7.96	ns
		MachXO2-4000HC-HE		7.51	—	7.71		8.01	ns
		MachXO2-7000HC-HE	_	7.54	—	7.75	—	8.06	ns
		MachXO2-256HC-HE	-0.06	_	-0.06		-0.06		ns
		MachXO2-640HC-HE	-0.06	_	-0.06	_	-0.06	_	ns
	Clock to Data Setup – PIO	MachXO2-1200HC-HE	-0.17	_	-0.17		-0.17		ns
t _{SU}	Input Register	MachXO2-2000HC-HE	-0.20	_	-0.20		-0.20		ns
		MachXO2-4000HC-HE	-0.23	_	-0.23	_	-0.23	_	ns
		MachXO2-7000HC-HE	-0.23	—	-0.23	_	-0.23	—	ns
		MachXO2-256HC-HE	1.75	_	1.95	_	2.16	—	ns
		MachXO2-640HC-HE	1.75	—	1.95	—	2.16	_	ns
	Clock to Data Hold – PIO Input	MachXO2-1200HC-HE	1.88	_	2.12		2.36	_	ns
t _H	Register	MachXO2-2000HC-HE	1.89	_	2.13	_	2.37	_	ns
		MachXO2-4000HC-HE	1.94	—	2.18	_	2.43	_	ns
		MachXO2-7000HC-HE	1.98	_	2.23	—	2.49	—	ns

Over Recommended Operating Conditions





			-	6	-	5	-4		
Parameter	Description	Device	Min.	Max.	Min.	Max.	Min.	Max.	Units
		MachXO2-256HC-HE	1.42	—	1.59	—	1.96	—	ns
		MachXO2-640HC-HE	1.41	—	1.58	—	1.96	—	ns
	Clock to Data Setup – PIO Input Register with Data Input	MachXO2-1200HC-HE	1.63		1.79		2.17		ns
		MachXO2-2000HC-HE	1.61		1.76		2.13		ns
		MachXO2-4000HC-HE	1.66	—	1.81	—	2.19	—	ns
		MachXO2-7000HC-HE	1.53	—	1.67	—	2.03	—	ns
		MachXO2-256HC-HE	-0.24	—	-0.24	—	-0.24	—	ns
		MachXO2-640HC-HE	-0.23	—	-0.23	—	-0.23	—	ns
•	Clock to Data Hold – PIO Input	MachXO2-1200HC-HE	-0.24	—	-0.24	—	-0.24	—	ns
t _{H_DEL}	Register with Input Data Delay	MachXO2-2000HC-HE	-0.23	—	-0.23	—	-0.23	—	ns
		MachXO2-4000HC-HE	-0.25	—	-0.25	—	-0.25	—	ns
		MachXO2-7000HC-HE	-0.21	_	-0.21		-0.21	—	ns
f _{MAX_IO}	Clock Frequency of I/O and PFU Register	All MachXO2 devices	_	388	_	323	_	269	MHz
General I/O	Pin Parameters (Using Edge C	lock without PLL)		l		l			
		MachXO2-1200HC-HE	_	7.53	—	7.76		8.10	ns
	Clock to Output – PIO Output	MachXO2-2000HC-HE		7.53	—	7.76		8.10	ns
t _{COE} Register		MachXO2-4000HC-HE		7.45	—	7.68		8.00	ns
		MachXO2-7000HC-HE	_	7.53	—	7.76		8.10	ns
	JE Clock to Data Setup – PIO Input Register	MachXO2-1200HC-HE	-0.19		-0.19	—	-0.19		ns
		MachXO2-2000HC-HE	-0.19		-0.19		-0.19		ns
t _{SUE}		MachXO2-4000HC-HE	-0.16		-0.16		-0.16		ns
		MachXO2-7000HC-HE	-0.19		-0.19		-0.19		ns
		MachXO2-1200HC-HE	1.97	_	2.24		2.52		ns
	Clock to Data Hold – PIO Input	MachXO2-2000HC-HE	1.97	_	2.24		2.52		ns
t _{HE}	Register	MachXO2-4000HC-HE	1.89		2.16	—	2.43		ns
		MachXO2-7000HC-HE	1.97		2.24	—	2.52		ns
		MachXO2-1200HC-HE	1.56		1.69	—	2.05		ns
	Clock to Data Setup - PIO	MachXO2-2000HC-HE	1.56		1.69	—	2.05		ns
t _{SU_DELE}	Input Register with Data Input Delay	MachXO2-4000HC-HE	1.74		1.88		2.25		ns
	Delay	MachXO2-7000HC-HE	1.66		1.81		2.17		ns
		MachXO2-1200HC-HE	-0.23		-0.23	—	-0.23		ns
	Clock to Data Hold – PIO Input	MachXO2-2000HC-HE	-0.23		-0.23		-0.23		ns
t _{H_DELE}	Register with Input Data Delay	MachXO2-4000HC-HE	-0.34		-0.34		-0.34		ns
		MachXO2-7000HC-HE	-0.29		-0.29		-0.29		ns
General I/O	Pin Parameters (Using Primar								
		MachXO2-1200HC-HE	_	5.97	_	6.00	_	6.13	ns
	Clock to Output – PIO Output	MachXO2-2000HC-HE	_	5.98	_	6.01	_	6.14	ns
t _{COPLL}	Register	MachXO2-4000HC-HE	_	5.99	_	6.02	_	6.16	ns
		MachXO2-7000HC-HE	_	6.02	_	6.06	_	6.20	ns
		MachXO2-1200HC-HE	0.36	_	0.36	_	0.65	_	ns
	Clock to Data Setup – PIO	MachXO2-2000HC-HE	0.36		0.36		0.63		ns
t _{SUPLL}	Input Register	MachXO2-4000HC-HE	0.35		0.35		0.62		ns
	_	MachXO2-7000HC-HE	0.34	_	0.34		0.59		ns
			0.01	l	0.01	l	0.00		



			-	-3	-	-2	- 1	1	
Parameter	Description	Device	Min.	Max.	Min.	Max.	Min.	Max.	Units
		MachXO2-1200ZE	0.66		0.68		0.80		ns
	Clock to Data Hold – PIO Input	MachXO2-2000ZE	0.68	—	0.70	—	0.83	—	ns
t _{HPLL}	Register	MachXO2-4000ZE	0.68	—	0.71	—	0.84	—	ns
		MachXO2-7000ZE	0.73	—	0.74	—	0.87	—	ns
-		MachXO2-1200ZE	5.14	—	5.69	—	6.20	—	ns
	Clock to Data Setup – PIO	MachXO2-2000ZE	5.11	—	5.67	—	6.17	—	ns
^t SU_DELPLL	Input Register with Data Input Delay	MachXO2-4000ZE	5.27	—	5.84		6.35	—	ns
		MachXO2-7000ZE	5.15	—	5.71	—	6.23	—	ns
-		MachXO2-1200ZE	-1.36	—	-1.36	—	-1.36	—	ns
		MachXO2-2000ZE	-1.35		-1.35		-1.35		ns
^t H_DELPLL		MachXO2-4000ZE	-1.43		-1.43		-1.43		ns
		MachXO2-7000ZE	-1.41		-1.41		-1.41		ns
Generic DDR	X1 Inputs with Clock and Data A	ligned at Pin Using P	CLK Pin	for Cloc	k Input -	- GDDR)	(1_RX.S	CLK.Ali	gned ^{9, 12}
t _{DVA}	Input Data Valid After CLK		—	0.382		0.401	—	0.417	UI
t _{DVE}	Input Data Hold After CLK	All MachXO2	0.670	—	0.684		0.693	—	UI
f _{DATA}	DDRX1 Input Data Speed	devices, all sides	_	140		116	—	98	Mbps
f _{DDRX1}	DDRX1 SCLK Frequency		_	70		58	—	49	MHz
	X1 Inputs with Clock and Data Ce	entered at Pin Using PO	LK Pin f	for Clock	Input –	GDDRX	1_RX.SC	LK.Cen	tered ^{9, 12}
t _{SU}	Input Data Setup Before CLK		1.319		1.412		1.462		ns
t _{HO}	Input Data Hold After CLK	All MachXO2	0.717	_	1.010		1.340		ns
f _{DATA}	DDRX1 Input Data Speed	devices, all sides	_	140		116	—	98	Mbps
f _{DDRX1}	DDRX1 SCLK Frequency		_	70		58	—	49	MHz
	X2 Inputs with Clock and Data A	ligned at Pin Using P	LK Pin	for Cloc	k Input -	GDDR	2_RX.E	CLK.Ali	gned ^{9, 12}
t _{DVA}	Input Data Valid After CLK		_	0.361		0.346	—	0.334	UI
t _{DVE}	Input Data Hold After CLK	MachXO2-640U,	0.602		0.625		0.648		UI
f _{DATA}	DDRX2 Serial Input Data Speed	MachXO2-1200/U and larger devices,	_	280	_	234	_	194	Mbps
f _{DDRX2}	DDRX2 ECLK Frequency	bottom side only ¹¹	_	140		117	—	97	MHz
f _{SCLK}	SCLK Frequency		_	70		59	—	49	MHz
	X2 Inputs with Clock and Data Ce	entered at Pin Using P	LK Pin f	for Clock	Input –	GDDRX	2_RX.EC	LK.Cen	tered ^{9, 12}
t _{SU}	Input Data Setup Before CLK		0.472		0.672		0.865		ns
t _{HO}	Input Data Hold After CLK	MachXO2-640U,	0.363	_	0.501		0.743		ns
f _{DATA}	DDRX2 Serial Input Data Speed	MachXO2-0400, MachXO2-1200/U and larger devices,		280	_	234	_	194	Mbps
f _{DDRX2}	DDRX2 ECLK Frequency	bottom side only ¹¹		140		117	_	97	MHz
f _{SCLK}	SCLK Frequency			70		59	_	49	MHz
	4 Inputs with Clock and Data A	ligned at Pin Using PC	LK Pin	for Cloc	k Input -	GDDRX	4_RX.E	CLK.Ali	gned ^{9, 12}
t _{DVA}	Input Data Valid After ECLK		_	0.307		0.316	_	0.326	UI
t _{DVE}	Input Data Hold After ECLK	MachXO2-640U,	0.662		0.650		0.649	_	UI
f _{DATA}	DDRX4 Serial Input Data Speed	MachXO2-1200/U and larger devices,	—	420	_	352	_	292	Mbps
f _{DDRX4}	DDRX4 ECLK Frequency	bottom side only ¹¹	_	210		176	_	146	MHz
f _{SCLK}	SCLK Frequency		<u> </u>	53	_	44	—	37	MHz
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sysCONFIG Port Timing Specifications

Symbol	Pa	Parameter		Max.	Units
All Configuration M	odes		1		
t _{PRGM}	PROGRAMN low p	oulse accept	55	—	ns
t _{PRGMJ}	PROGRAMN low p	PROGRAMN low pulse rejection			ns
t _{INITL}	INITN low time	INITN low time LCMXO2-256			μs
		LCMXO2-640	—	35	μs
		LCMXO2-640U/ LCMXO2-1200	—	55	μs
		LCMXO2-1200U/ LCMXO2-2000	—	70	μs
		LCMXO2-2000U/ LCMXO2-4000	—	105	μs
		LCMXO2-7000	_	130	μs
t _{DPPINIT}	PROGRAMN low to	o INITN low	—	150	ns
t _{DPPDONE}	PROGRAMN low to	o DONE low	—	150	ns
t _{IODISS}	PROGRAMN low to	o I/O disable	—	120	ns
Slave SPI			•		
f _{MAX}	CCLK clock freque	ncy	—	66	MHz
t _{CCLKH}	CCLK clock pulse	width high	7.5	—	ns
t _{CCLKL}	CCLK clock pulse	width low	7.5	—	ns
t _{STSU}	CCLK setup time		2	—	ns
t _{STH}	CCLK hold time		0	—	ns
t _{STCO}	CCLK falling edge	to valid output	—	10	ns
t _{STOZ}	CCLK falling edge	to valid disable	—	10	ns
t _{STOV}	CCLK falling edge	to valid enable	—	10	ns
t _{SCS}	Chip select high tin	ne	25	—	ns
t _{SCSS}	Chip select setup t	ime	3	—	ns
t _{SCSH}	Chip select hold tin	ne	3	—	ns
Master SPI	·				
f _{MAX}	MCLK clock freque	ency	—	133	MHz
t _{MCLKH}	MCLK clock pulse	MCLK clock pulse width high		—	ns
t _{MCLKL}	MCLK clock pulse	width low	3.75	—	ns
t _{STSU}	MCLK setup time		5	—	ns
t _{STH}	MCLK hold time		1	—	ns
t _{CSSPI}	INITN high to chip	select low	100	200	ns
t _{MCLK}	INITN high to first I	VCLK edge	0.75	1	μs



I²C Port Timing Specifications^{1, 2}

Symbol	Parameter	Min.	Max.	Units
f _{MAX}	Maximum SCL clock frequency	_	400	kHz

1. MachXO2 supports the following modes:

• Standard-mode (Sm), with a bit rate up to 100 kbit/s (user and configuration mode)

• Fast-mode (Fm), with a bit rate up to 400 kbit/s (user and configuration mode)

2. Refer to the I²C specification for timing requirements.

SPI Port Timing Specifications¹

Symbol	Parameter	Min.	Max.	Units
f _{MAX}	Maximum SCK clock frequency		45	MHz

1. Applies to user mode only. For configuration mode timing specifications, refer to sysCONFIG Port Timing Specifications table in this data sheet.

Switching Test Conditions

Figure 3-13 shows the output test load used for AC testing. The specific values for resistance, capacitance, voltage, and other test conditions are shown in Table 3-5.

Figure 3-13. Output Test Load, LVTTL and LVCMOS Standards



Table 3-5. Test Fixture Required Components,	Non-Terminated Interfaces
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Test Condition	R1	CL	Timing Ref.	VT
		0pF	LVTTL, LVCMOS 3.3 = 1.5 V	—
			LVCMOS 2.5 = $V_{CCIO}/2$	—
LVTTL and LVCMOS settings (L -> H, H -> L)	∞		LVCMOS 1.8 = $V_{CCIO}/2$	—
			LVCMOS 1.5 = $V_{CCIO}/2$	—
			LVCMOS 1.2 = $V_{CCIO}/2$	—
LVTTL and LVCMOS 3.3 (Z -> H)			1.5 V	V _{OL}
LVTTL and LVCMOS 3.3 (Z -> L)			1.5 V	V _{OH}
Other LVCMOS (Z -> H)	188	0pF	V _{CCIO} /2	V _{OL}
Other LVCMOS (Z -> L)	100	opi	V _{CCIO} /2	V _{OH}
LVTTL + LVCMOS (H -> Z)			V _{OH} – 0.15 V	V _{OL}
LVTTL + LVCMOS (L -> Z)]		V _{OL} – 0.15 V	V _{OH}

Note: Output test conditions for all other interfaces are determined by the respective standards.



Ordering Information

MachXO2 devices have top-side markings, for commercial and industrial grades, as shown below:



Notes:

- 1. Markings are abbreviated for small packages.
- 2. See PCN 05A-12 for information regarding a change to the top-side mark logo.



Ultra Low Power Commercial Grade Devices, Halogen Free (RoHS) Packaging

Part Number	LUTs	Supply Voltage	Grade	Package	Leads	Temp.
LCMXO2-256ZE-1SG32C	256	1.2 V	-1	Halogen-Free QFN	32	COM
LCMXO2-256ZE-2SG32C	256	1.2 V	-2	Halogen-Free QFN	32	COM
LCMXO2-256ZE-3SG32C	256	1.2 V	-3	Halogen-Free QFN	32	COM
LCMXO2-256ZE-1UMG64C	256	1.2 V	-1	Halogen-Free ucBGA	64	COM
LCMXO2-256ZE-2UMG64C	256	1.2 V	-2	Halogen-Free ucBGA	64	COM
LCMXO2-256ZE-3UMG64C	256	1.2 V	-3	Halogen-Free ucBGA	64	COM
LCMXO2-256ZE-1TG100C	256	1.2 V	-1	Halogen-Free TQFP	100	COM
LCMXO2-256ZE-2TG100C	256	1.2 V	-2	Halogen-Free TQFP	100	COM
LCMXO2-256ZE-3TG100C	256	1.2 V	-3	Halogen-Free TQFP	100	COM
LCMXO2-256ZE-1MG132C	256	1.2 V	-1	Halogen-Free csBGA	132	COM
LCMXO2-256ZE-2MG132C	256	1.2 V	-2	Halogen-Free csBGA	132	COM
LCMXO2-256ZE-3MG132C	256	1.2 V	-3	Halogen-Free csBGA	132	COM

Part Number	LUTs	Supply Voltage	Grade	Package	Leads	Temp.
LCMXO2-640ZE-1TG100C	640	1.2 V	-1	Halogen-Free TQFP	100	COM
LCMXO2-640ZE-2TG100C	640	1.2 V	-2	Halogen-Free TQFP	100	COM
LCMXO2-640ZE-3TG100C	640	1.2 V	-3	Halogen-Free TQFP	100	COM
LCMXO2-640ZE-1MG132C	640	1.2 V	-1	Halogen-Free csBGA	132	COM
LCMXO2-640ZE-2MG132C	640	1.2 V	-2	Halogen-Free csBGA	132	COM
LCMXO2-640ZE-3MG132C	640	1.2 V	-3	Halogen-Free csBGA	132	COM

Part Number	LUTs	Supply Voltage	Grade	Package	Leads	Temp.
LCMXO2-1200ZE-1SG32C	1280	1.2 V	-1	Halogen-Free QFN	32	COM
LCMXO2-1200ZE-2SG32C	1280	1.2 V	-2	Halogen-Free QFN	32	COM
LCMXO2-1200ZE-3SG32C	1280	1.2 V	-3	Halogen-Free QFN	32	COM
LCMXO2-1200ZE-1TG100C	1280	1.2 V	-1	Halogen-Free TQFP	100	COM
LCMXO2-1200ZE-2TG100C	1280	1.2 V	-2	Halogen-Free TQFP	100	COM
LCMXO2-1200ZE-3TG100C	1280	1.2 V	-3	Halogen-Free TQFP	100	COM
LCMXO2-1200ZE-1MG132C	1280	1.2 V	-1	Halogen-Free csBGA	132	COM
LCMXO2-1200ZE-2MG132C	1280	1.2 V	-2	Halogen-Free csBGA	132	COM
LCMXO2-1200ZE-3MG132C	1280	1.2 V	-3	Halogen-Free csBGA	132	COM
LCMXO2-1200ZE-1TG144C	1280	1.2 V	-1	Halogen-Free TQFP	144	COM
LCMXO2-1200ZE-2TG144C	1280	1.2 V	-2	Halogen-Free TQFP	144	COM
LCMXO2-1200ZE-3TG144C	1280	1.2 V	-3	Halogen-Free TQFP	144	COM



Part Number	LUTs	Supply Voltage	Grade	Package	Leads	Temp.
LCMXO2-4000HC-4QN84I	4320	2.5 V / 3.3 V	-4	Halogen-Free QFN	84	IND
LCMXO2-4000HC-5QN84I	4320	2.5 V / 3.3 V	-5	Halogen-Free QFN	84	IND
LCMXO2-4000HC-6QN84I	4320	2.5 V / 3.3 V	-6	Halogen-Free QFN	84	IND
LCMXO2-4000HC-4TG144I	4320	2.5 V / 3.3 V	-4	Halogen-Free TQFP	144	IND
LCMXO2-4000HC-5TG144I	4320	2.5 V / 3.3 V	-5	Halogen-Free TQFP	144	IND
LCMXO2-4000HC-6TG144I	4320	2.5 V / 3.3 V	-6	Halogen-Free TQFP	144	IND
LCMXO2-4000HC-4MG132I	4320	2.5 V / 3.3 V	-4	Halogen-Free csBGA	132	IND
LCMXO2-4000HC-5MG132I	4320	2.5 V / 3.3 V	-5	Halogen-Free csBGA	132	IND
LCMXO2-4000HC-6MG132I	4320	2.5 V / 3.3 V	-6	Halogen-Free csBGA	132	IND
LCMXO2-4000HC-4BG256I	4320	2.5 V / 3.3 V	-4	Halogen-Free caBGA	256	IND
LCMXO2-4000HC-5BG256I	4320	2.5 V / 3.3 V	-5	Halogen-Free caBGA	256	IND
LCMXO2-4000HC-6BG256I	4320	2.5 V / 3.3 V	-6	Halogen-Free caBGA	256	IND
LCMXO2-4000HC-4FTG256I	4320	2.5 V / 3.3 V	-4	Halogen-Free ftBGA	256	IND
LCMXO2-4000HC-5FTG256I	4320	2.5 V / 3.3 V	-5	Halogen-Free ftBGA	256	IND
LCMXO2-4000HC-6FTG256I	4320	2.5 V / 3.3 V	-6	Halogen-Free ftBGA	256	IND
LCMXO2-4000HC-4BG332I	4320	2.5 V / 3.3 V	-4	Halogen-Free caBGA	332	IND
LCMXO2-4000HC-5BG332I	4320	2.5 V / 3.3 V	-5	Halogen-Free caBGA	332	IND
LCMXO2-4000HC-6BG332I	4320	2.5 V / 3.3 V	-6	Halogen-Free caBGA	332	IND
LCMXO2-4000HC-4FG484I	4320	2.5 V / 3.3 V	-4	Halogen-Free fpBGA	484	IND
LCMXO2-4000HC-5FG484I	4320	2.5 V / 3.3 V	-5	Halogen-Free fpBGA	484	IND
LCMXO2-4000HC-6FG484I	4320	2.5 V / 3.3 V	-6	Halogen-Free fpBGA	484	IND

Part Number	LUTs	Supply Voltage	Grade	Package	Leads	Temp.
LCMXO2-7000HC-4TG144I	6864	2.5 V / 3.3 V	-4	Halogen-Free TQFP	144	IND
LCMXO2-7000HC-5TG144I	6864	2.5 V / 3.3 V	-5	Halogen-Free TQFP	144	IND
LCMXO2-7000HC-6TG144I	6864	2.5 V / 3.3 V	-6	Halogen-Free TQFP	144	IND
LCMXO2-7000HC-4BG256I	6864	2.5 V / 3.3 V	-4	Halogen-Free caBGA	256	IND
LCMXO2-7000HC-5BG256I	6864	2.5 V / 3.3 V	-5	Halogen-Free caBGA	256	IND
LCMXO2-7000HC-6BG256I	6864	2.5 V / 3.3 V	-6	Halogen-Free caBGA	256	IND
LCMXO2-7000HC-4FTG256I	6864	2.5 V / 3.3 V	-4	Halogen-Free ftBGA	256	IND
LCMXO2-7000HC-5FTG256I	6864	2.5 V / 3.3 V	-5	Halogen-Free ftBGA	256	IND
LCMXO2-7000HC-6FTG256I	6864	2.5 V / 3.3 V	-6	Halogen-Free ftBGA	256	IND
LCMXO2-7000HC-4BG332I	6864	2.5 V / 3.3 V	-4	Halogen-Free caBGA	332	IND
LCMXO2-7000HC-5BG332I	6864	2.5 V / 3.3 V	-5	Halogen-Free caBGA	332	IND
LCMXO2-7000HC-6BG332I	6864	2.5 V / 3.3 V	-6	Halogen-Free caBGA	332	IND
LCMXO2-7000HC-4FG400I	6864	2.5 V / 3.3 V	-4	Halogen-Free fpBGA	400	IND
LCMXO2-7000HC-5FG400I	6864	2.5 V / 3.3 V	-5	Halogen-Free fpBGA	400	IND
LCMXO2-7000HC-6FG400I	6864	2.5 V / 3.3 V	-6	Halogen-Free fpBGA	400	IND
LCMXO2-7000HC-4FG484I	6864	2.5 V / 3.3 V	-4	Halogen-Free fpBGA	484	IND
LCMXO2-7000HC-5FG484I	6864	2.5 V / 3.3 V	-5	Halogen-Free fpBGA	484	IND
LCMXO2-7000HC-6FG484I	6864	2.5 V / 3.3 V	-6	Halogen-Free fpBGA	484	IND